## Notice of References Cited Application/Control No. 10/796,141 Examiner Lee Lum Applicant(s)/Patent Under Reexamination OTAKI ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,568,499	05-2003	Nakazawa et al.	180/422
	В	US-6,298,941	10-2001	Spadafora, William Glenn	180/422
	С	US-6,886,657	05-2005	Yokota et al.	180/422
	D	US-6,880,668	04-2005	Sakaki et al.	180/441
	Е	US-6,193,009	02-2001	Chino et al.	180/441
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US- '			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Φ.					
	ø					
	æ			-113-51111-2		
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.